

# Micromegas in Xe-TMA mixtures at high pressure: an update

F.J. Iguaz

On behalf of University of Zaragoza

## Outline

- Introduction
- Summary of published results.
- The Si-MM setup.
- New results: mean electron lifetime & drift velocity.
- Conclusions & outlook.



**Universidad**  
Zaragoza

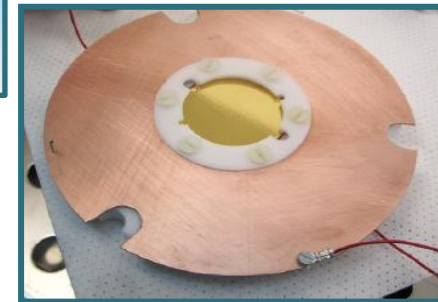
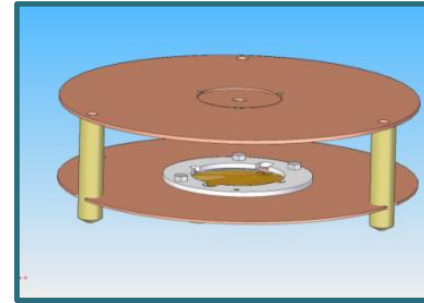
# Introduction

- **Study of Penning mixtures:** an additive gas with ionization potential below and closer to the first metastable level of the main gas. Better performance expected: higher gain, better energy resolution.
- **For Xenon,** these mixtures are attractive for **double beta decay** as the Fano factor may be reduced, keeping the good scintillator properties of Xenon (D. Nygren *et al.*, *J. Phys. Conf. Ser.* **309** (2011) 012006).
- **Results:** S.Cebrian *et al.*, *JINST* **8** (2013) P01012, arXiv:1210:3287.
- **This talk:** attachment effects & drift velocity measurement.
- **Plans:** new microbulk MM detectors of 25 & 50  $\mu\text{m}$  gap with different hole diameters & pitch distances will be characterized in Xe-TMA mixtures. Already tested in  $\text{Ar}+2\%\text{iC}_4\text{H}_{10}$ .

# Experimental setup & procedure

## Setup:

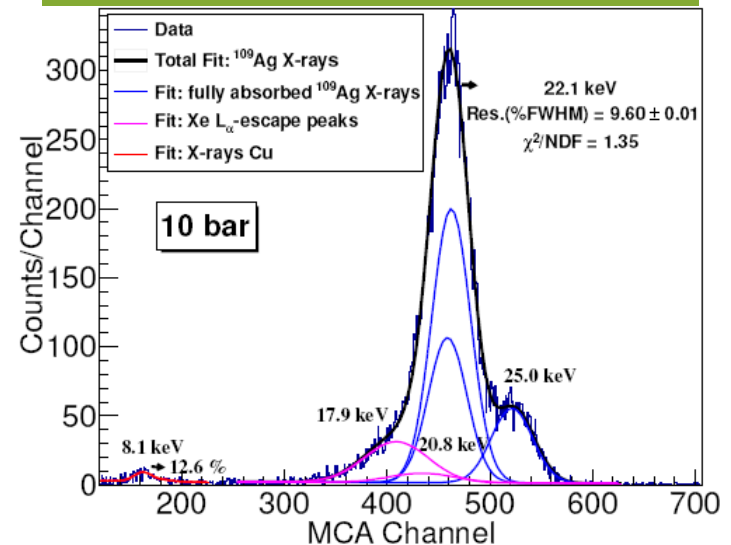
- Gas & vacuum systems.
- Mass spectrometer.
- Stainless steel vessel of 2 liters.
- Drift distance of 1 cm.
- Circular microbulk MM detector (35 mm diameter, 50  $\mu\text{m}$  gap).



## Procedure:

- Vessel pumped & baked out.
- Gas introduced & recirculated by a SAES filter during the data-taking.
- Determination of the operating point for a fixed amplification field.
- Gain & energy resolution measured.
- Gas composition measured.
- Gas recovery.

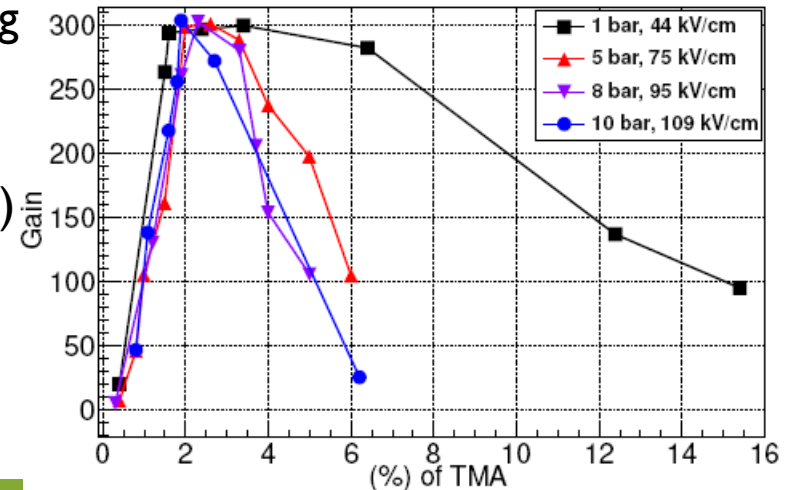
## Energy spectrum by $^{109}\text{Cd}$



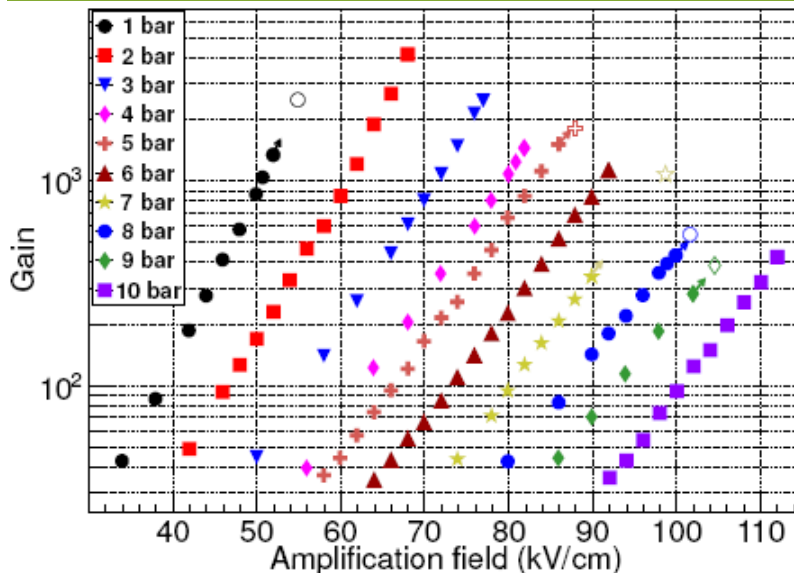
# Published results

- Xe-TMA mixtures at 1-10 pressures, using a  $^{109}\text{Cd}$  source (22.1 keV x-rays).
- Best performance for 1.5-2.5% TMA.
- Maximum gain of  $2 \times 10^3$  ( $5 \times 10^2$ ) at 1 (10) bar, i.e., x3 than in pure xenon.
- Energy resolution: 7.3 (9.6) % FWHM at 22.1 keV for 1 (10) bar, i.e., a factor 2 (3) better than in pure xenon.

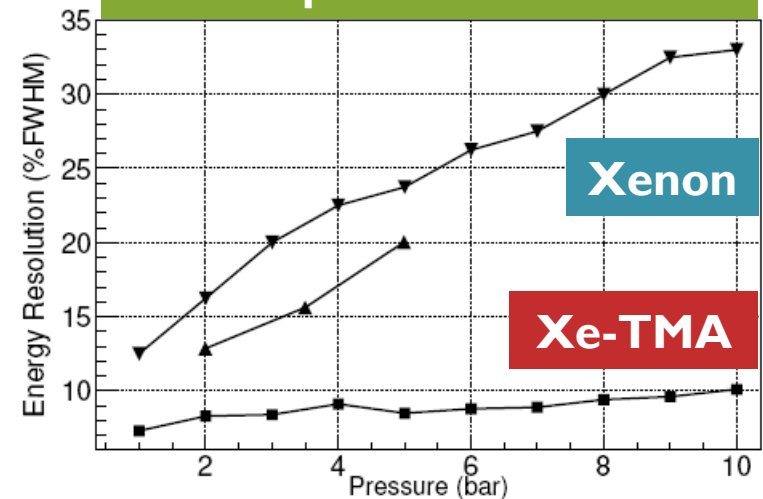
## Gain vs %TMA for a fixed amplification field



## Gain vs Eamp for 2%TMA & 1-10 bar



## Gain vs %TMA for a fixed amplification field

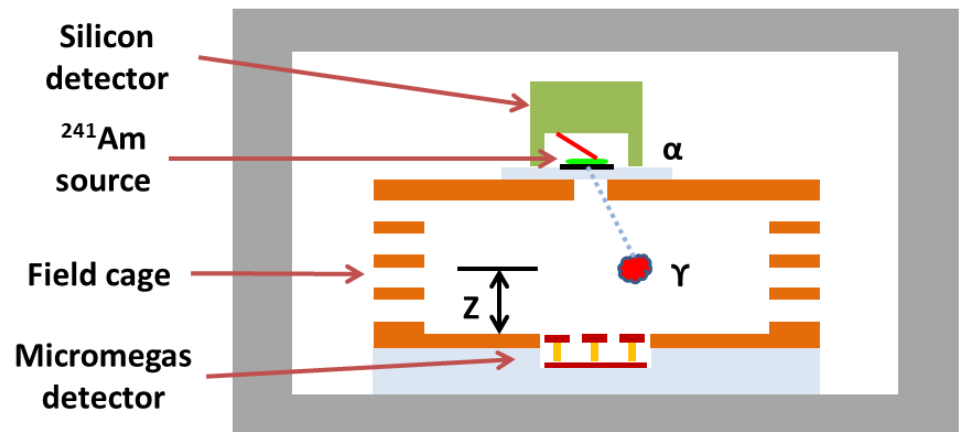


# The Si-MM setup: Motivation

- Xe-TMA measurements made with  $< 30$  ppm  $O_2$ . Evidence that attachment effects were little but no measurement made.
- $^{241}\text{Am}$ : a 5.5 MeV alpha & gammas (26.3 or 59.5 MeV) in coincidence.
- The gamma may deposit its energy in the fiducial volume, creating a cluster of electrons. They will then drift and induce a signal at the mM.
- If the alpha is detected by the Si detector, the time difference between both signals is just the drift time of electrons.

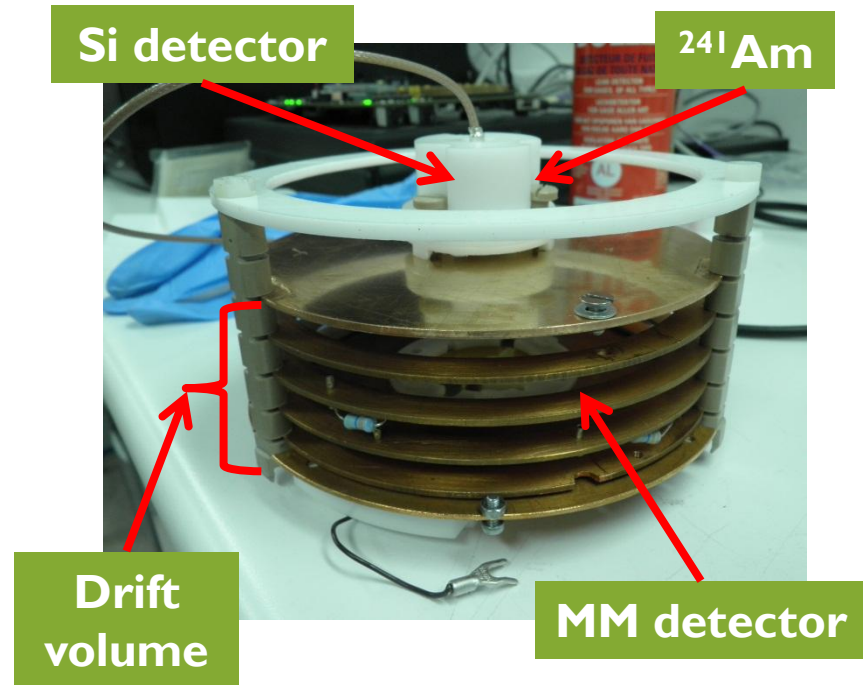
Good measurement of:

- Mean electron lifetime (gas purity, attachment coefficients)
- Drift velocity in Xe-TMA (comparison with Magboltz).



# The Si-MM setup: Photos & runs

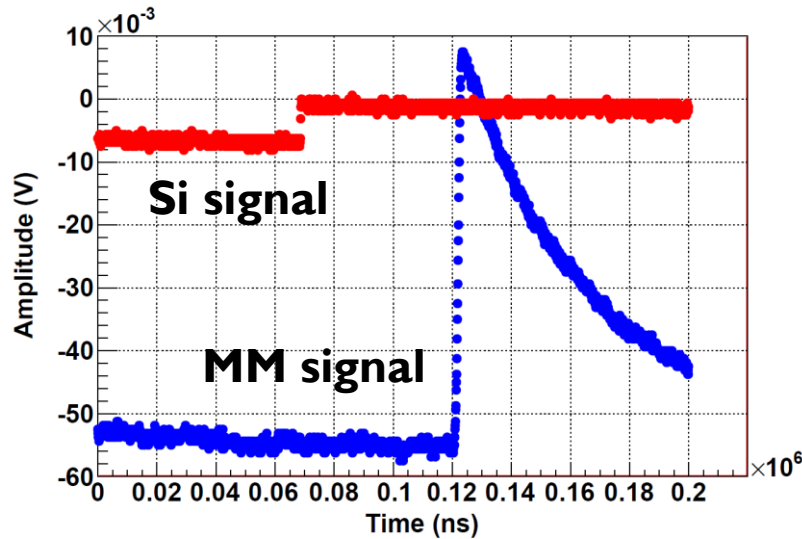
- Same vessel & gas/vacuum systems.
- The  $^{241}\text{Am}$  source & the Silicon photo-diode are encapsulated in a plastic piece to isolate them from the cathode.
- The drift volume (4 cm distance) is composed of copper rings, linked by resistors, to make uniform the field.
- Si & MM signals were acquired by an oscilloscope for an offline analysis.
- Three set of runs were taken, in different gas conditions.



1 <sup>st</sup> set:	2.0%TMA, 4 bar	Close gas mode ( $\sim 2000$ ppm $\text{O}_2$ )
2 <sup>nd</sup> set:	3.5%TMA, 4-6 bar	Recirculation mode ( $< 45$ ppm $\text{O}_2$ )
3 <sup>rd</sup> set:	1.5%TMA, 3-6 bar	Recirculation mode (15-45 ppm $\text{O}_2$ )

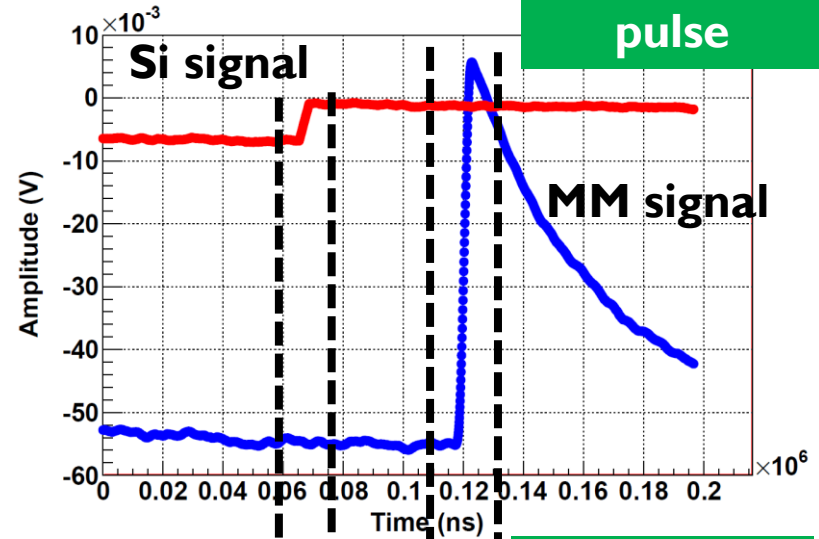
# Some words about the off-line analysis

## Raw pulse

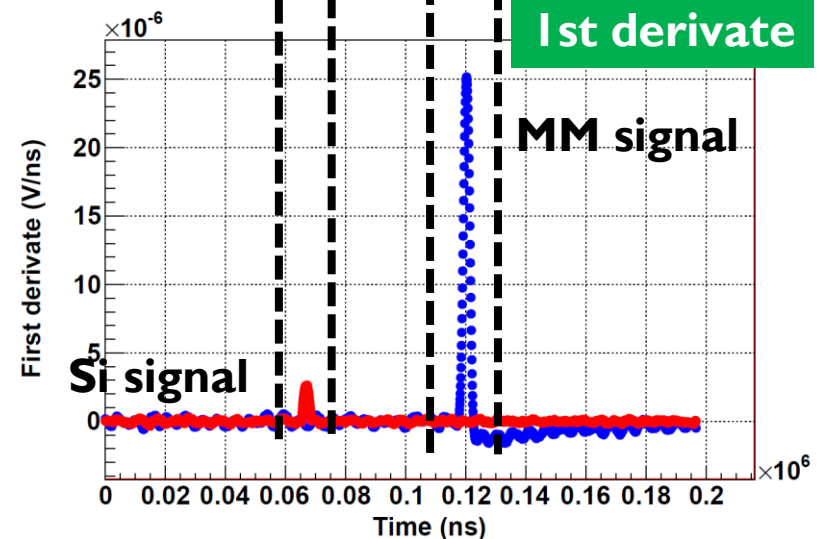


- The first derivate is first used to find the temporal position of each pulse & a window to analyze pulses.
- Pulses are then smoothed, making the mean of each point with 10 on the left & 10 on the right.
- Finally, the smooth pulse is used to calculate the amplitude & risetime.

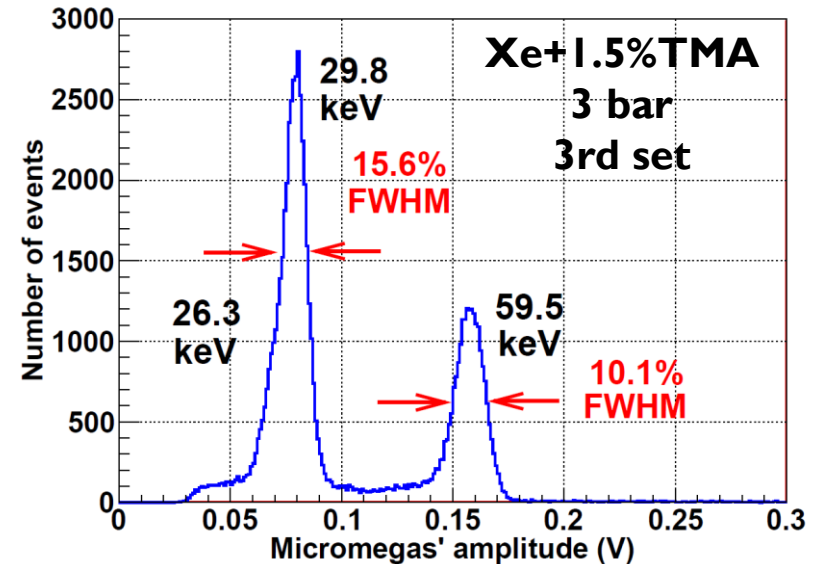
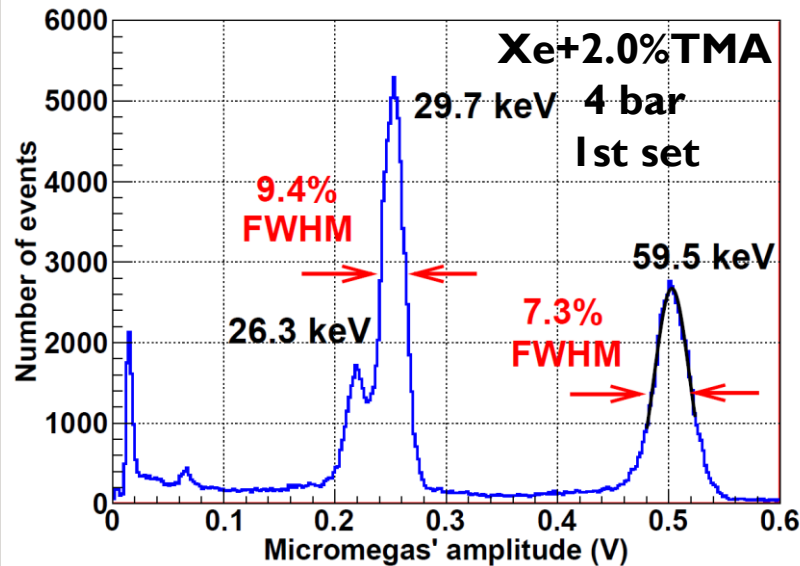
## Smoothed pulse



## 1st derivate



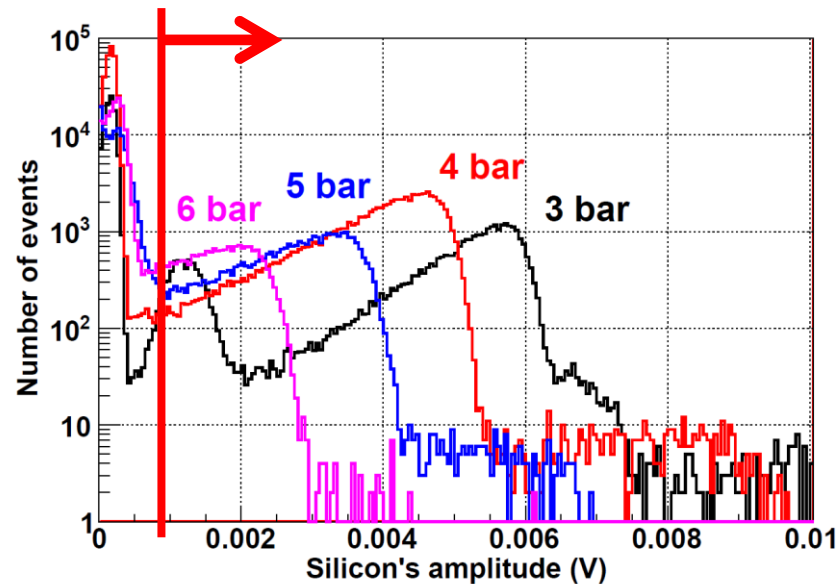
# Energy spectrum of $\mu\text{M}$ detector



- The two  $\gamma$  peaks of  $^{241}\text{Am}$  observed in spectrum (& a escape peak).
- Resolution: 9.4% (1<sup>st</sup> set) & 23.2% (2<sup>nd</sup>) & 15.6% FWHM (3<sup>rd</sup>) at 29.8 keV.
- Worst values for 2<sup>nd</sup> & 3<sup>rd</sup> sets due to worse detector performance (reused detector, lower gain). Still good enough for measuring the drift velocity & attachment effects (3<sup>rd</sup> set).

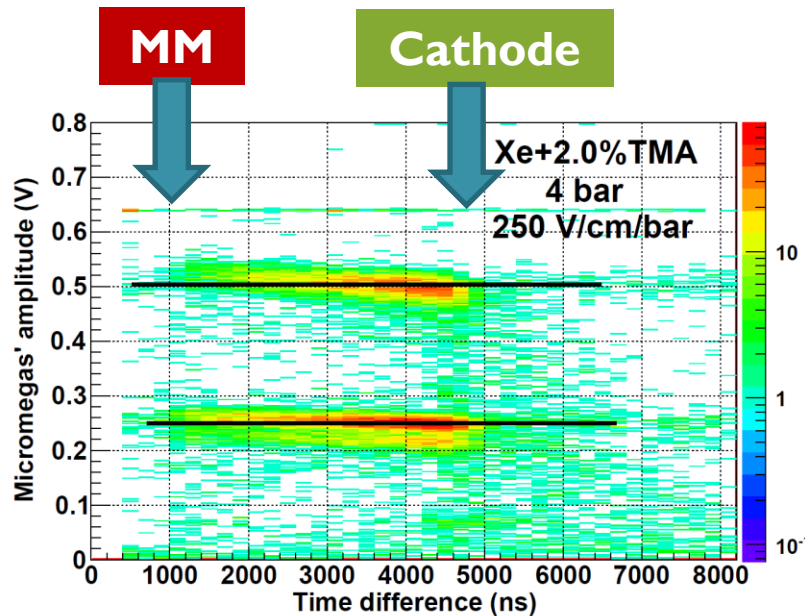


# Selection of Si-MM coincidences

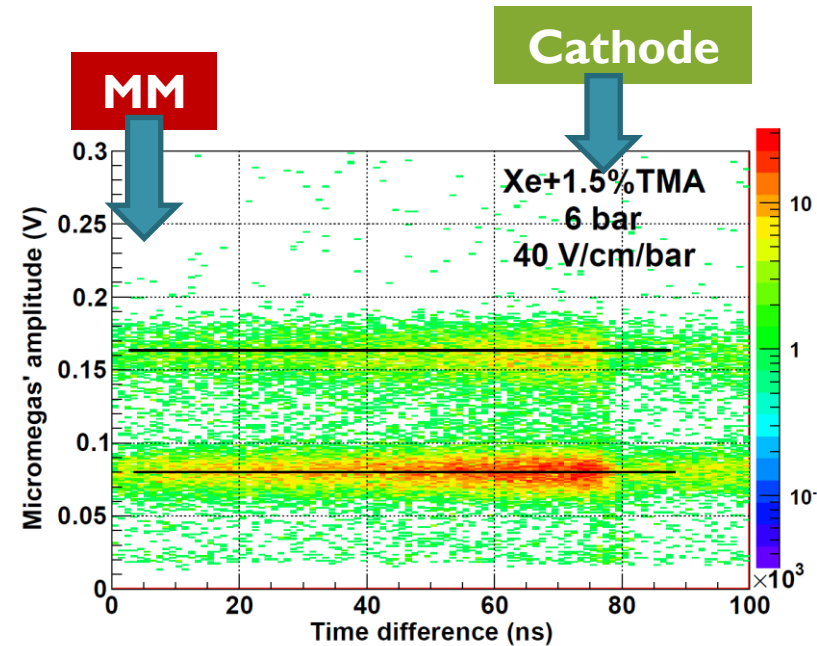


- A pulse is always found in our analysis.
- No pulse means amplitude compatible with baseline variations.
- Si-MM coincidences are selected by a threshold in Si amplitude.
- Si signals are weaker when pressure is increased (not observed at 8 bar).
- Thresholds: 5 mV (1<sup>st</sup> set) & 1-2 mV (2<sup>nd</sup>-3<sup>rd</sup> set).

# Correlation of MM amplitude vs Si-MM time difference



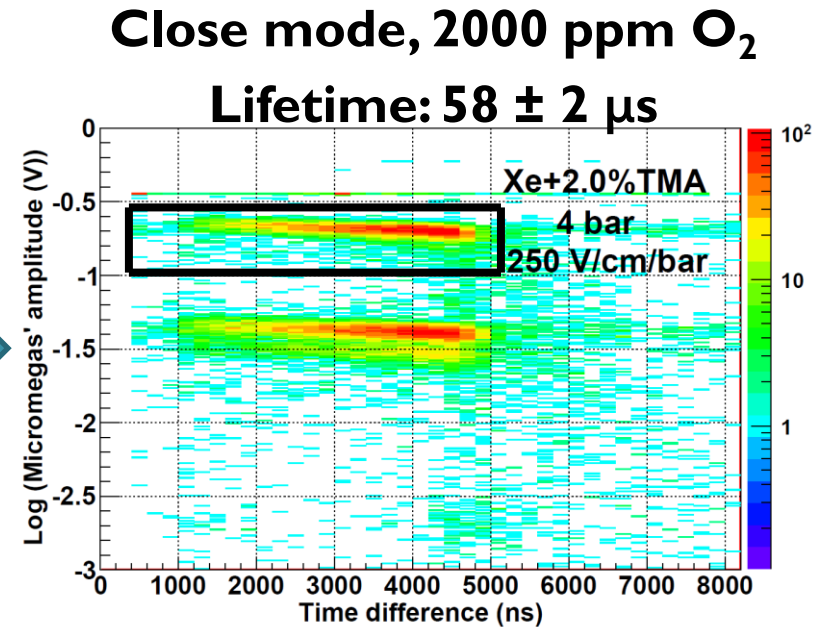
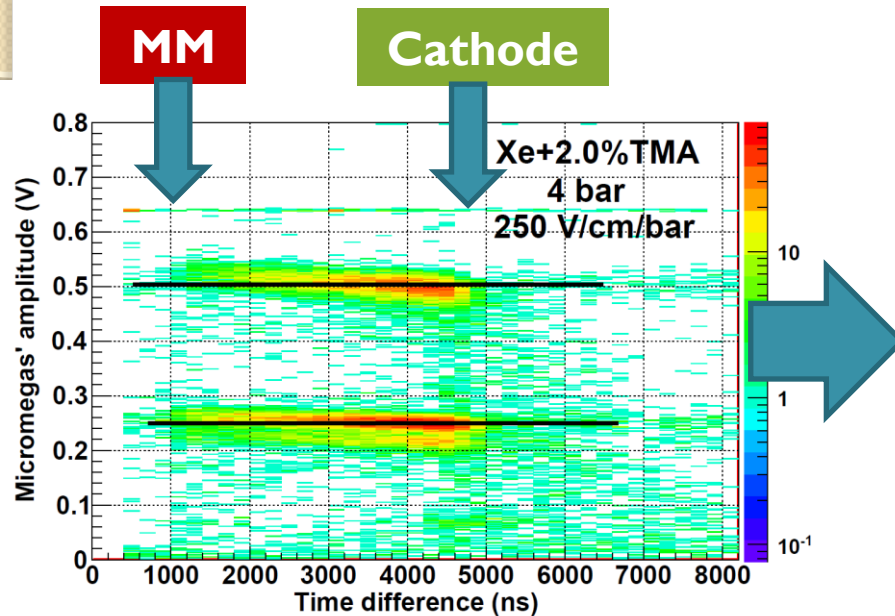
**Close mode, ~2000 ppm O<sub>2</sub>**  
**Lifetime:  $58 \pm 2 \mu\text{s}$**



**Recirculation, 45 ppm O<sub>2</sub>**  
**Lifetime > 7.8 ms at 90% CL**

- Note the differences between a dirty & a clean situation!!!
- The mean electron lifetime can be calculated in both cases.

# The mean electron lifetime ( $\tau$ )



- MM amplitude into log scale.
- Selection of events at 59.5 keV peak.
- A linear fit to all points is then made.
- If mean value of slope is compatible with zero, a lower limit can be set from the deviation.

$$N(t) = N(0) \exp\left(-\frac{t}{\tau}\right)$$

$$\log(\text{Amp}) = \log(\text{Amp}_0) - \frac{1}{\tau} \Delta t$$

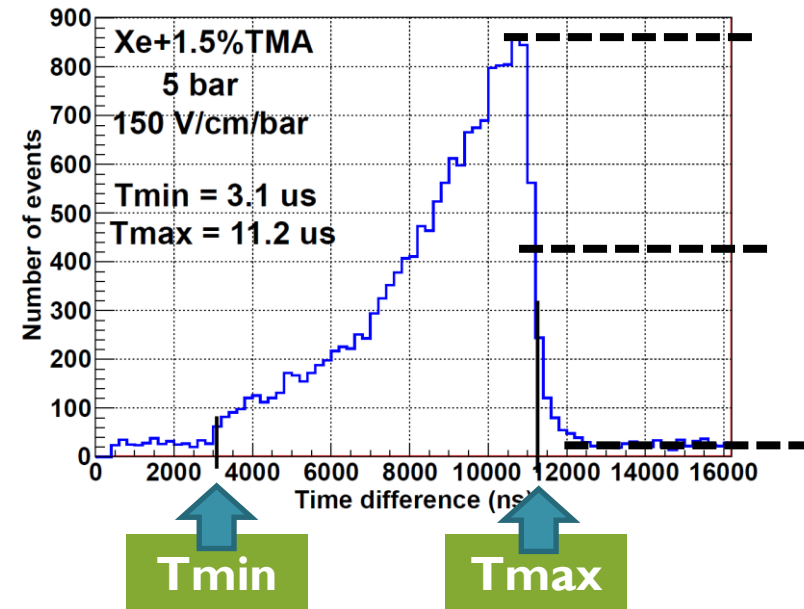
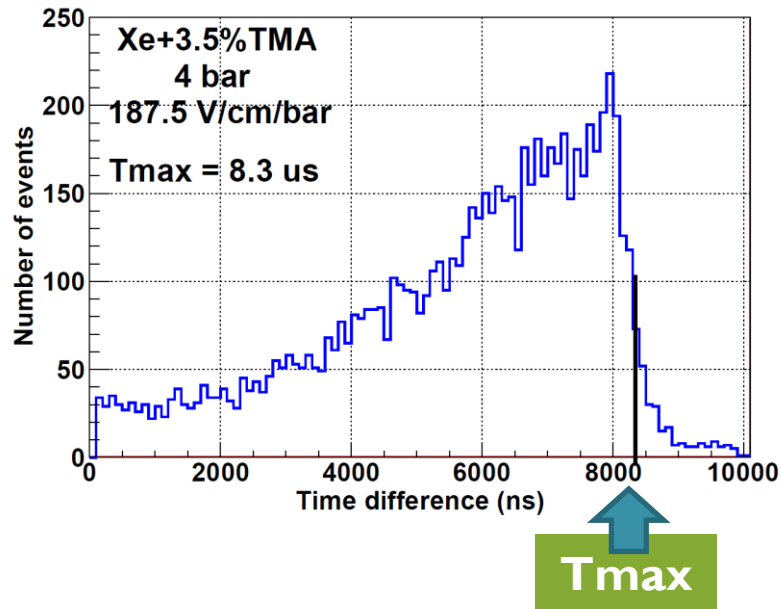
$$\tau > \frac{1}{2} \sigma \text{ at } 90\% \text{ CL}$$

# Measured mean electron lifetime in Xe-TMA mixtures

Pressure bar	Reduced drift field (V/cm/bar)		
	50	75	100
3.0	> 5.9 ms	—	2.2 ± 0.6 ms
4.0	3.6 ± 0.5 ms	> 4.3 ms	> 6.0 ms
5.0	> 3.8 ms	> 5.3 ms	> 2.1 ms
6.0	> 7.8 ms	> 2.8 ms	—

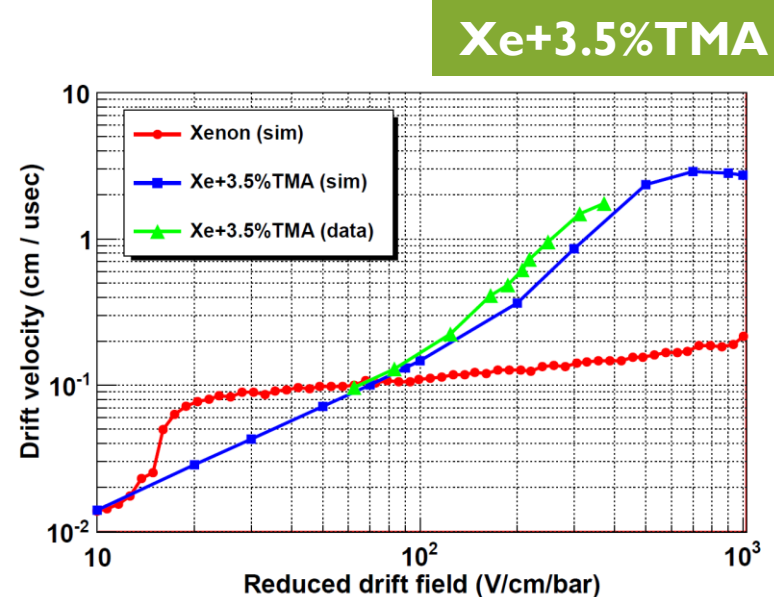
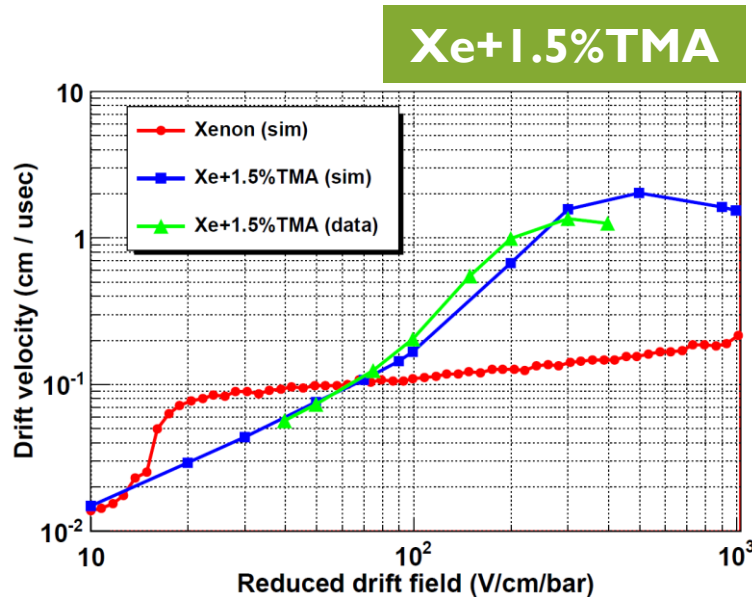
- A limit of **5 ms** set for **3-6 bar** and fields **>50-100 V/cm/bar**.
- For a fix pressure, the mean electron lifetime improves when drift field is increased, except for some fit limitations.
- Worst value (**2.2 ± 0.6 ms**) set just after gas filling (recirculation of 30 min & outgassing rate  $4 \times 10^{-5}$  mbar l/seg). Improved along time.

# Time difference distributions



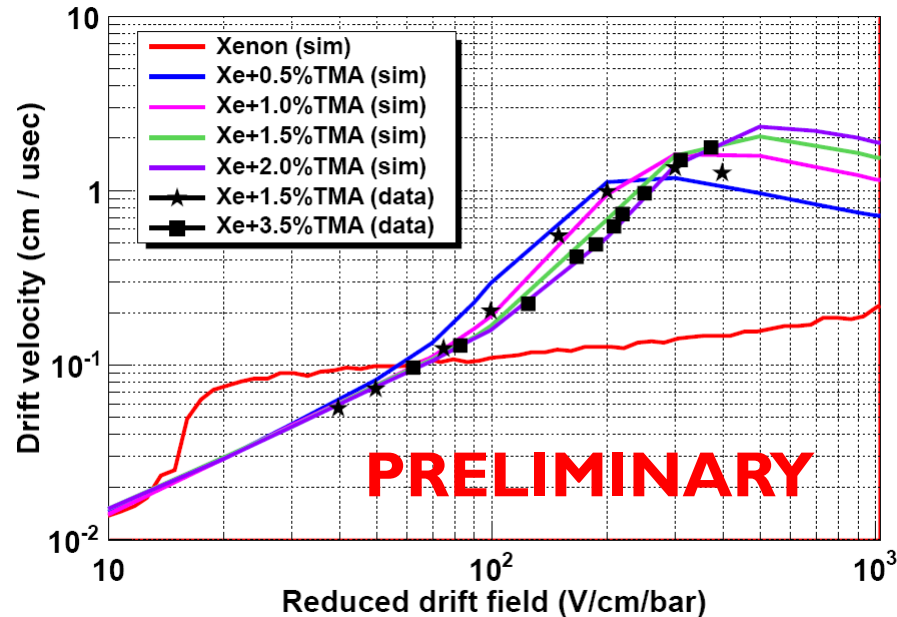
- 2<sup>nd</sup> set: Minimum at 0  $\mu s$  for the time difference.
- 3<sup>rd</sup> set: Different minima observed, correlated with the MM amplifier integration time (longer time, higher minimum).
- The minimum (MM) & maximum (cathode) of each time difference distribution were calculated from the edges.

# Measured drift velocity vs Magboltz 9.0.1



- Drift velocity calculated dividing the drift distance (4 cm) by the difference between the maximum & minimum of time differences.
- Values does not match with Magboltz 9.0.1, within errors (< 10%).
- There is a divergence for drift fields higher than 100 V/cm/bar.
- As a first cross-check, the gas composition analysis (method & calibrations made) is being reviewed now.

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# Conclusions and outlook

## Conclusions

- ⌘ A Si-MM setup has been installed in our system to measure both attachment effects & drift velocity in Xe-TMA mixtures.
- ⌘ In recirculation mode, no clear attachment effects observed in our gas (4 cm of drift), in agreement with published data ( $< 30$  ppm  $O_2$ ).
- ⌘ A minimum value of **5 ms** (90% CL) set for **3-6 bar**.
- ⌘ The drift velocity for Xe + 1.5 & 3.5% TMA mixtures has been measured, with clear divergences with Magboltz 9.0.1 for fields over 100 V/cm/bar. The gas composition analysis is being reviewed.

## Outlook

- ⌘ More precise results for attachment & drift velocity are expected for NEXT-MM due to its longer drift distance ( $\sim 30$  cm).
- ⌘ New MM's of 25 & 50  $\mu\text{m}$  gap with different hole diameters & pitch distances will be characterized in Xe-TMA mixtures.

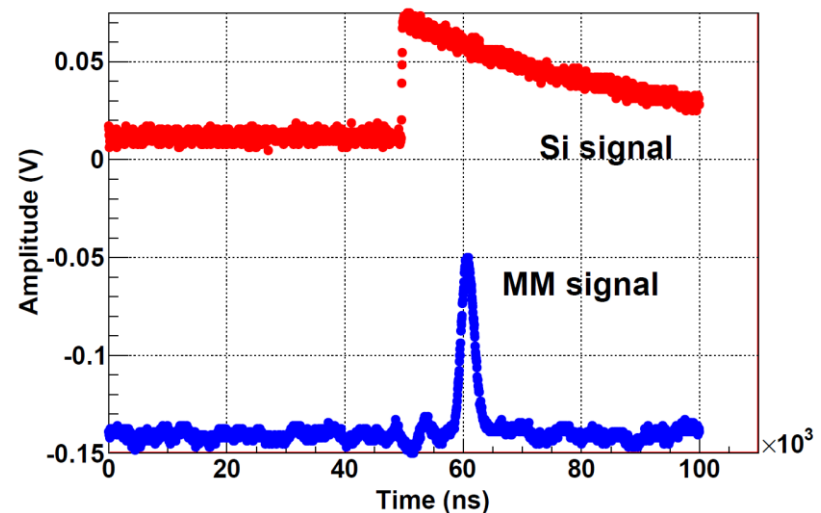
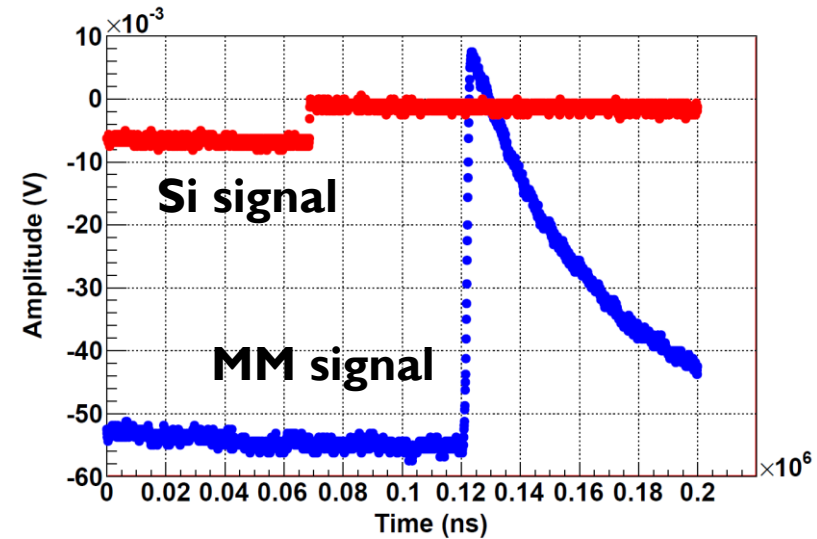




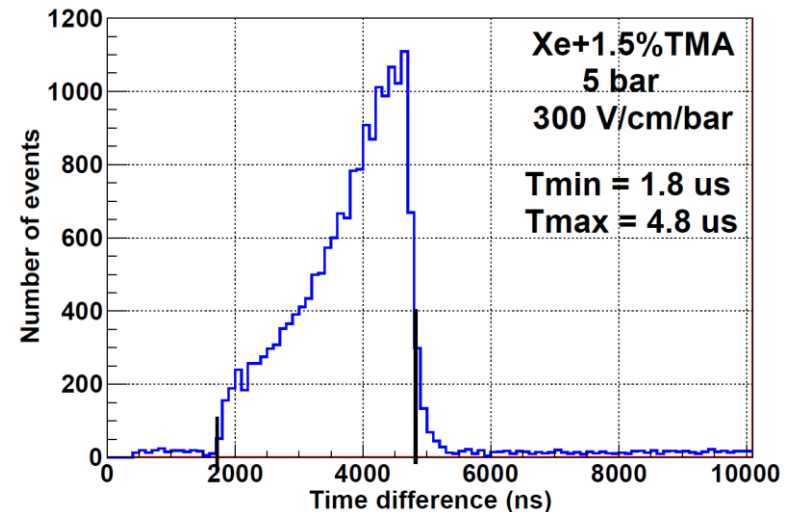
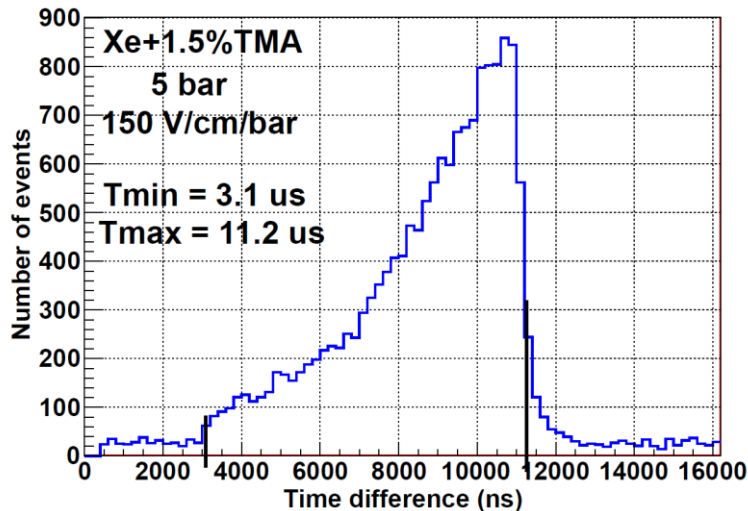
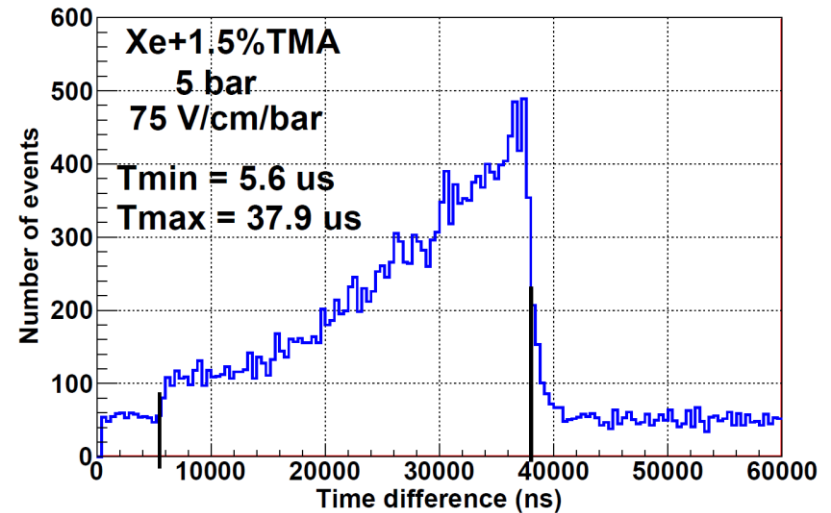
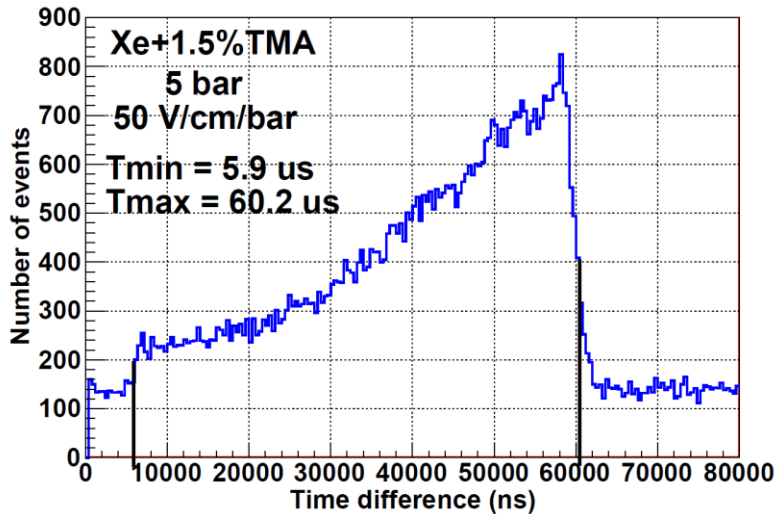
# BACK-UP

# Some words about the DAQ

- 1st & 2nd set of runs:
  - Xe+2.0%TMA (1st, dirty gas)
  - Xe+3.5%TMA (2nd, clean gas)
  - Si signal: ORTEC pre.
  - MM signal: CANBERRA pre.
  - Oscilloscope trigger: MM signal.
  - Time situation: 1st derivative's maximum.
- 3rd set of runs:
  - Xe+1.5%TMA (clean gas)
  - Si signal: CANBERRA pre.
  - MM signal: ORTEC pre + CANBERRA amplifier (0.5 – 2 us).
  - Oscilloscope trigger: MM signal.
  - Time situation: Pulse's maximum.



# Time difference distributions for Xe+1.5%TMA at 5 bar



# Time difference distributions for Xe+3.5%TMA at 4 bar

